

### PN Junction Built in Potential:

$$\vec{J}_n^{drift+diff} = en\mu_n \vec{E}_x + eD_n \frac{dn(x)}{dx}$$

$$\vec{E}(x) = -\frac{d\phi}{dx} \left[ \frac{D_n}{\mu_n} = \frac{D_p}{\mu_p} = \left(\frac{kT}{e}\right) \right]$$

$$0=(q)\{n(x)\}(\mu_n)\left(\vec{E}_x+V_T\frac{dn(x)}{dx}\frac{1}{n(x)}\right)$$

$$\int d\phi = \int V_T \frac{dn(x)}{n(x)}$$

$$\phi_n - \phi_p = V_T \ln n(x) \Big|_{n_{p0}}^{n_{n0}}$$

$$\phi_n - \phi_p = V_T \ln \frac{n_{n0}}{n_{p0}} = V_T \ln \left[ \frac{n_{n0}}{1} \frac{1}{n_{p0}} \right]$$

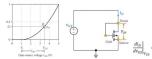


 $\vec{E}(x) = \int \frac{\rho(x)}{\varepsilon_{Si}} dx = \int \frac{(-q)N_A}{\varepsilon_{Si}} dx = \frac{(-q)N_A}{\varepsilon_{Si}} x + C_1$ 

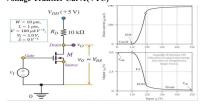
# The n-MOSFET- $t_D$ vs. $v_{DS}$ Characteristics cont'd.

## Transcond in the diode mode operation:

$$g_m = k * V_{OV} = 2 \frac{I_D}{V_{OV}} = \sqrt{2k * I_D}$$



# Voltage Transfer Curve(VTC)



# DC analysis with Multiple diodes:

- opens).

  Find voltage drops across all opens.

  Identify all the open voltage drops that could bring the diode in its place to forward bias.
- From all the open voltage drops that could bring the diode in its place to forward bias, SHORT the open with

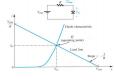
- diode in its place to forward bias, SHORT the open with the highest voltage drop.

  5. Discarding all previous calculations, repeat circuit analysis for the remaining opens.

  6. Repeat steps 2-5 iill the state (fides is DPEN or SHORT) for the last open has been obtained.

  7. Final answer: After the states (fides is DPEN or SHORT) of all the opens have been determined, discard all previous calculations and repeat circuit analysis one last time with correctly applied states (diode is OPEN or SHORT) for all the opens.

# Diode Circuits: Operating Point

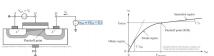


### Mosfets: MOS Capacitor:



 $V_{GB}(Q=0)=-\phi_0$  (flatband) Onset of strong inversion @  $\phi(0) = -\phi_p$ 

 $V_{GB0} = -\phi_0 - 2\phi_p - \frac{Q_{b0}}{C_0 x}$ 



MOSFET channel resistance in ohmic Region (  $r_{DS}$  ):

$$i_D = k(V_{GS} - V_t)v_{DS}$$
 ,  $r_{DS} = \frac{v_DS}{i_D} = \frac{1}{k*V_{OV}}$ 

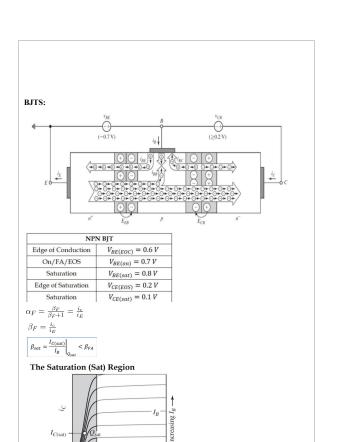
MOSFET channel resistance in Saturation Region(  $r_o$  ):

$$\left[i_D = \frac{1}{2}k(1 + \lambda \nu_{DS})(V_{OV})^2\right], \quad \left|\frac{1}{r_o} = \frac{\partial i_D}{\partial \nu_{DS}}\right],$$

$$\frac{\partial i_D}{\partial \nu_{DS}} = \frac{1}{2} k (V_{OV})^2 \lambda = \left[ \frac{1}{2} k (V_{OV})^2 \right] \lambda = I_{D(EOS)} \lambda , \quad r_o = \frac{1}{\lambda I_D(EOS)}$$

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 $V_{CE(\text{sat})}$   $V_{CE(\text{EOS})}$  (0.1 V) (0.2 V)

Voltage Divider Biasing BJT:

